

n-Channel Power MOSFET

OptiMOS™
BSB029P03NX3

Data Sheet

1.92, 2011-03-21
Preliminary

Industrial & Multimarket

1 Description

OptiMOS™ P3 -30V products are class leading power P-Channel MOSFETs for highest power density and energy efficient solutions. Lowest on state resistance in small footprint packages make OptiMOS™ P3 -30V the best choice for the demanding requirements of load switch, high-side switch and battery management applications. OptiMOS™ P3 products are available in high performance packages to tackle your most challenging applications giving full flexibility in optimizing space, efficiency and cost.

Features

- **P-Channel MOSFET**
- Very low on-resistance $R_{DS(on)}$
- Qualified for consumer level application
- Pb-free plating; RoHS compliant
- Halogen-free according to IEC61249-2-21
- Double sided cooling
- Compatible with DirectFET® package MX footprint and outline¹⁾
- 100% avalanche tested
- Low parasitic inductance
- Low profile (<0.7 mm)

Applications

- Load switch
- High-side switch
- Battery management

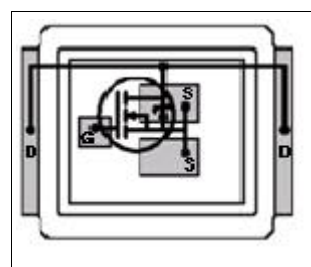


Table 1 Key Performance Parameters

Parameter	Value	Unit	Related Links
V_{DS}	-30	V	IFX OptiMOS webpage IFX OptiMOS product brief IFX OptiMOS spice models IFX Design tools
$R_{DS(on),max}$	2.9	mΩ	
I_D	137	A	
Q_{OSS}	106	nC	
$Q_{g,typ}$	66		

Type	Package	Marking
BSB029P03LX3 G	MG-WDSO-2	5103

1) DirectFET® is a trademark of International Rectifier Corporation. BSB027P03LX3 G uses DirectFET® technology licensed from International Rectifier Corporation

2 Maximum ratings

at $T_j = 25\text{ °C}$, unless otherwise specified.

Table 2 Maximum ratings

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Continuous drain current	I_D	-	-	137	A	$V_{GS}=10\text{ V}$, $T_C=25\text{ °C}$
				87		$V_{GS}=10\text{ V}$, $T_C=100\text{ °C}$
				26		$V_{GS}=10\text{ V}$, $T_A=25\text{ °C}$, $R_{thJA}=45\text{ K/W}$ ¹⁾
Pulsed drain current ²⁾	$I_{D,pulse}$	-	-	400		$T_C=25\text{ °C}$
Avalanche current, single pulse ³⁾	I_{AS}			40		$T_C=25\text{ °C}$
Avalanche energy, single pulse	E_{AS}	-	-	290	mJ	$I_D=40\text{ A}$, $R_{GS}=25\text{ }\Omega$
Gate source voltage	V_{GS}	-20	-	20	V	
Power dissipation	P_{tot}	-	-	78	W	$T_C=25\text{ °C}$
				2.8		$T_A=25\text{ °C}$, $R_{thJA}=45$ ¹⁾ K/W
Operating and storage temperature	T_j, T_{stg}	-40	-	150	°C	
IEC climatic category; DIN IEC 68-1		55/150/56				

1) Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6cm² (one layer, 70 µm thick) copper area for drain connection. PCB is vertical in still air

2) See figure 3 for more detailed information

3) See figure 13 for more detailed information

3 Thermal characteristics

Table 3 Thermal characteristics

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Thermal resistance, junction - case	R_{thJC}	-	1.0	-	°K/W	bottom
		-	-	1.6		top
Device on PCB	R_{thJA}	-	-	45		6 cm ² cooling area ¹⁾

1) Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm² (one layer, 70µm thick) copper area for drain conneciton. PCB is vertical in still air.

4 Electrical characteristics

Electrical characteristics, at $T_j=25\text{ °C}$, unless otherwise specified.

Table 4 Static characteristics

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Drain-source breakdown voltage	$V_{(BR)DSS}$	30	-	-	V	$V_{GS}=0\text{ V}$, $I_D=1\text{ mA}$
Gate threshold voltage	$V_{GS(th)}$	-1.9	-2.5	-3.1		$V_{DS}=V_{GS}$, $I_D=250\text{ }\mu\text{A}$
Zero gate voltage drain current	I_{DSS}	-	0.1	10	μA	$V_{DS}=30\text{ V}$, $V_{GS}=0\text{ V}$, $T_j=25\text{ °C}$
		-	10	100		$V_{DS}=30\text{ V}$, $V_{GS}=0\text{ V}$, $T_j=125\text{ °C}$
Gate-source leakage current	I_{GSS}	-	10	100	nA	$V_{GS}=20\text{ V}$, $V_{DS}=0\text{ V}$
Drain-source on-state resistance	$R_{DS(on)}$	-	3.4	4.2	$\text{m}\Omega$	$V_{GS}=6\text{ V}$, $I_D=20\text{ A}$
		-	2.4	2.9		$V_{GS}=10\text{ V}$, $I_D=30\text{ A}$
Gate resistance	R_G	-	2.5	-	Ω	
Transconductance	g_{fs}	48	95		S	$ V_{DS} >2 I_{D} R_{DS(on)max}$, $I_D=30\text{ A}$

Table 5 Dynamic characteristics

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Input capacitance	C_{iss}	-	10000	15000	pF	$V_{GS}=0\text{ V}$, $V_{DS}=15\text{ V}$, $f=1\text{ MHz}$
Output capacitance	C_{oss}	-	4600	6100		
Reverse transfer capacitance	C_{rss}	-	340	510		
Turn-on delay time	$t_{d(on)}$	-	27	41	ns	$V_{DD}=15\text{ V}$, $V_{GS}=10\text{ V}$, $I_D=30\text{ A}$, $R_G=1.6\text{ }\Omega$
Rise time	t_r	-	10	15		
Turn-off delay time	$t_{d(off)}$	-	62	93		
Fall time	t_f	-	12	18		

Electrical characteristics
Table 6 Gate charge characteristics¹⁾

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Gate to source charge	Q_{gs}	-	40	53	nC	$V_{DD}=15\text{ V}$, $I_D=30\text{ A}$, $V_{GS}=0\text{ to }4.5\text{ V}$
Gate charge at threshold	$Q_{g(th)}$		16	22		
Gate to drain charge	Q_{gd}	-	18	30		
Switching charge	Q_{sw}	-	41	61		
Gate charge total	Q_g		66	88		
Gate plateau voltage	$V_{plateau}$	-	3.9	-	V	
Gate charge total	Q_g		138	183	nC	$V_{DD}=15\text{ V}$, $I_D=30\text{ A}$, $V_{GS}=0\text{ to }10\text{ V}$
Gate charge total, sync. FET	$Q_{g(sync)}$		56	75		$V_{DS}=0.1\text{ V}$, $V_{GS}=0\text{ to }4.5\text{ V}$
Output charge	Q_{oss}		106	142		$V_{DD}=15\text{ V}$, $V_{GS}=0\text{ V}$

1) See figure 16 for gate charge parameter definition

Table 7 Reverse diode characteristics

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Diode continuous forward current	I_s			78	A	$T_C=25\text{ °C}$
Diode pulse current	$I_{s,pulse}$			400		
Diode forward voltage	V_{SD}	-	0.8	1.0	V	$V_{GS}=0\text{ V}$, $I_F=30\text{ A}$, $T_j=25\text{ °C}$
Reverse recovery charge	Q_{rr}	-	116	145	nC	$V_R=15\text{ V}$, $I_F=I_s$, $di_F/dt=400\text{ A}/\mu\text{s}$

5 Electrical characteristics diagrams

Table 8

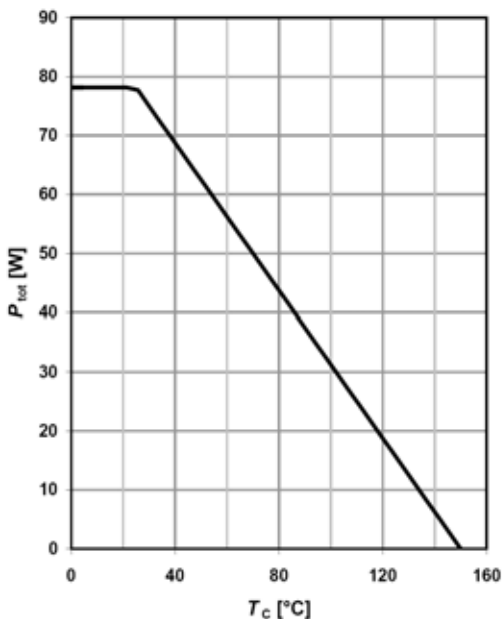
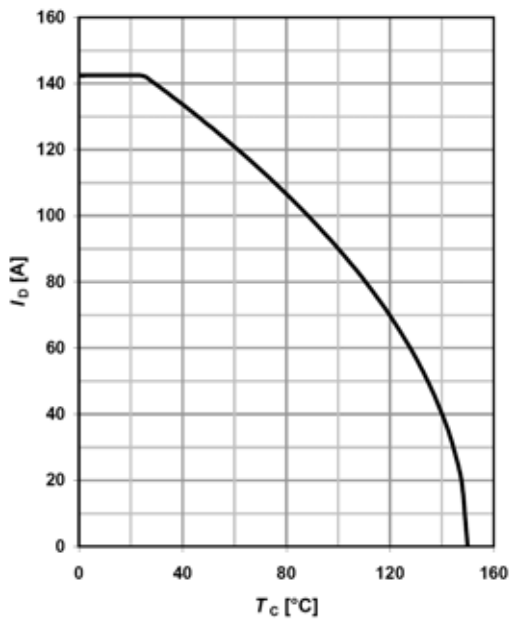
1 Power dissipation	2 Drain current
 $P_{\text{tot}} = f(T_c)$	 $I_D = f(T_c)$; parameter: V_{GS}

Table 9

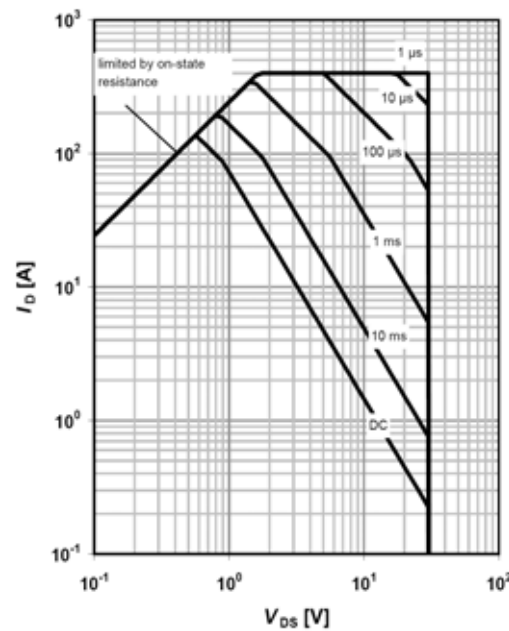
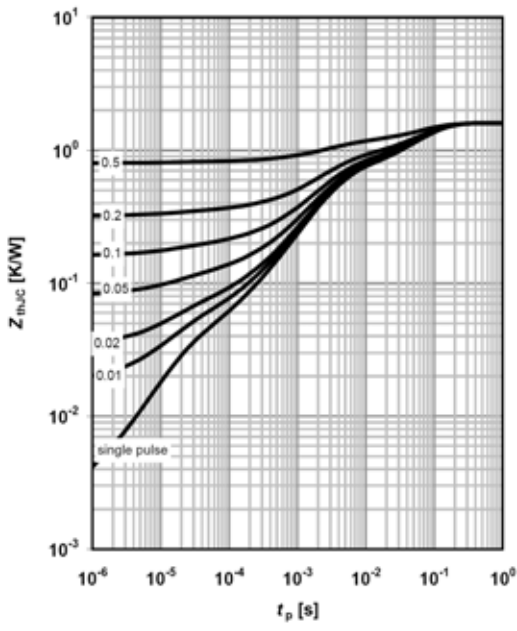
3 Safe operating area $T_c=25\text{ °C}$	4 Max. transient thermal impedance
 $I_D = f(V_{DS})$; $T_J = 25\text{ °C}$; $D=0$; parameter: T_p	 $Z_{(thJC)} = f(t_p)$; parameter: $D = t_p / T$

Table 10

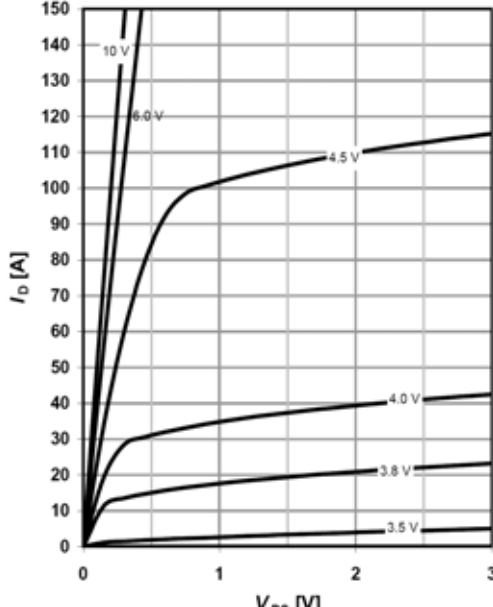
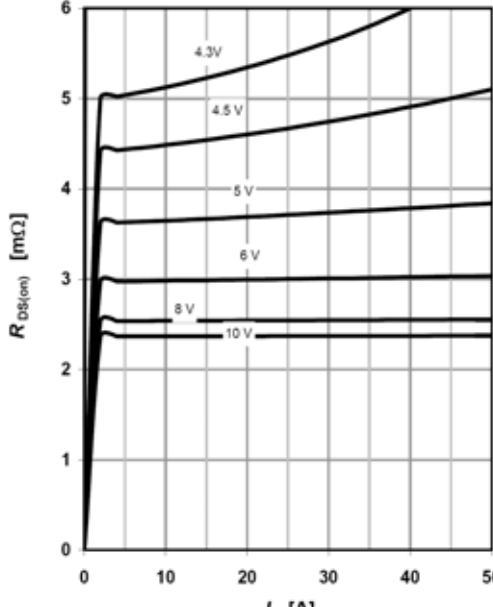
5 Typ. output characteristics $T_c=25\text{ }^{\circ}\text{C}$	6 Typ. drain-source on-state resistance
	
$I_D=f(V_{DS}); T_J=25\text{ }^{\circ}\text{C}; \text{parameter: } V_{GS}$	$R_{DS(on)}=f(I_D); T_J=25\text{ }^{\circ}\text{C}; \text{parameter: } V_{GS}$

Table 11

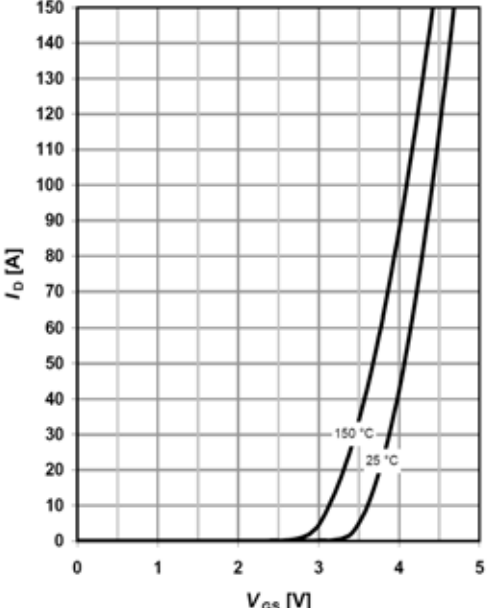
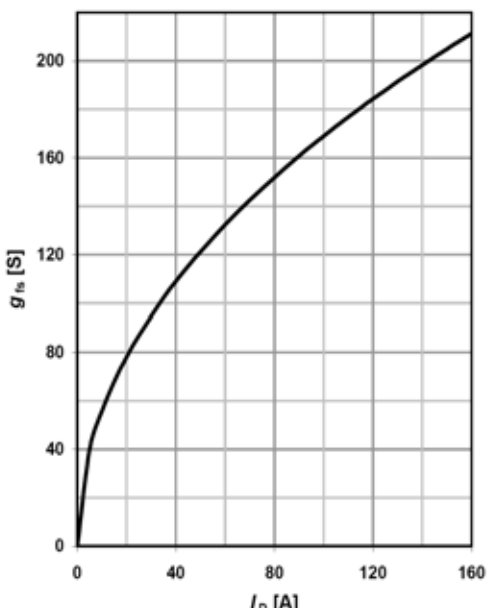
7 Typ. transfer characteristics	8 Typ. forward transconductance
	
$I_D=f(V_{GS}); V_{DS} >2 I_D R_{DS(on)max}$	$g_{fs}=f(I_D); T_J=25\text{ }^{\circ}\text{C}$

Table 12

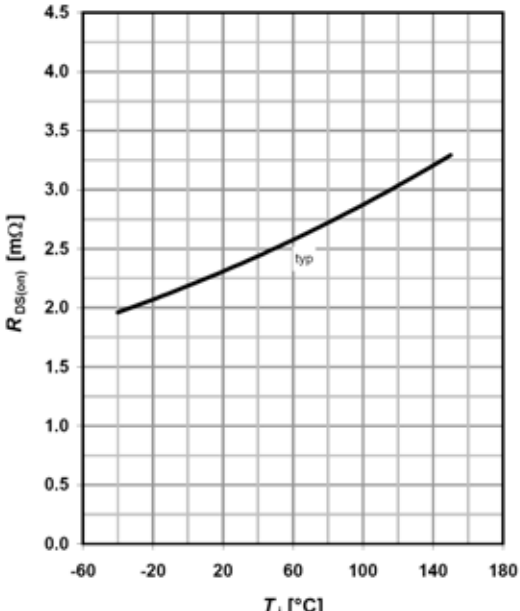
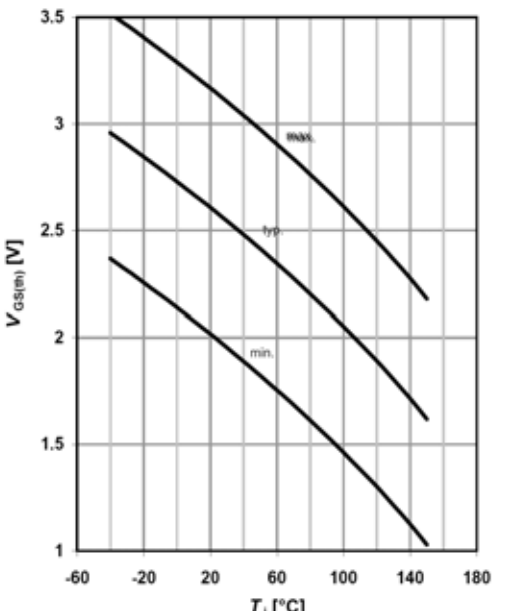
9 Drain-source on-state resistance	10 Typ. gate threshold voltage
	
$R_{DS(on)} = f(T_J); I_D = 30 \text{ A}; V_{GS} = 10 \text{ V}$	$V_{GS(th)} = f(T_J); V_{GS} = V_{DS}; I_D = 250 \mu\text{A}$

Table 13

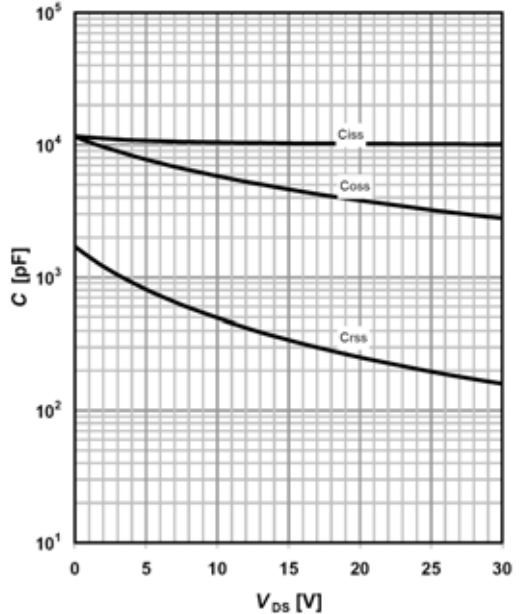
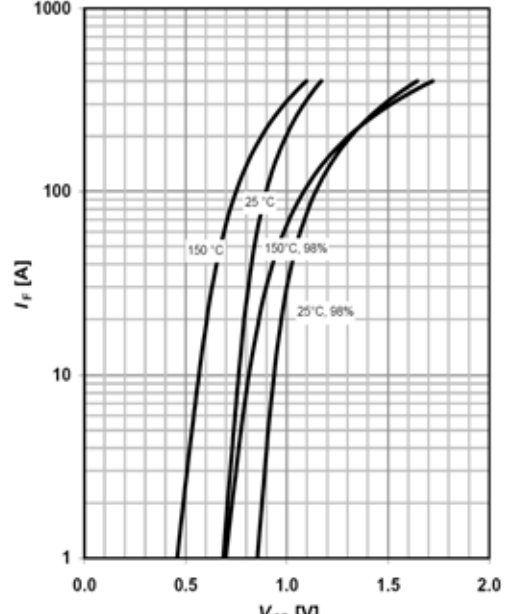
11 Typ. capacitances	12 Forward characteristics of reverse diode
	
$C = f(V_{DS}); V_{GS} = 0 \text{ V}; f = 1 \text{ MHz}$	$I_F = f(V_{SD}); \text{parameter: } T_J$

Table 14

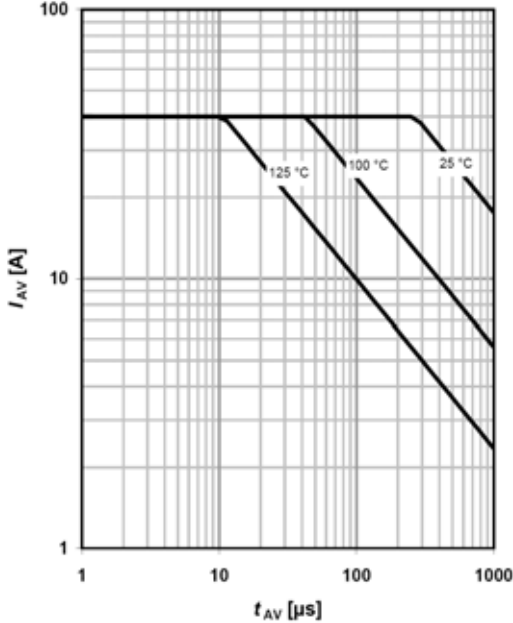
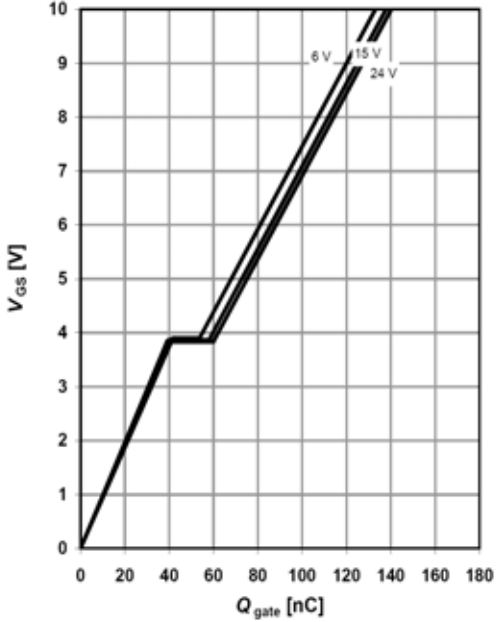
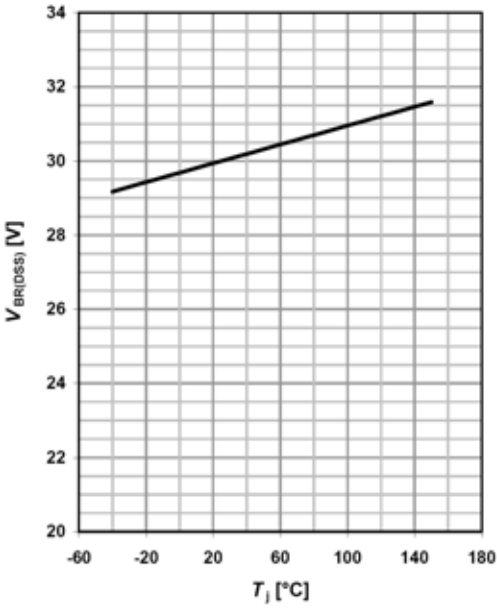
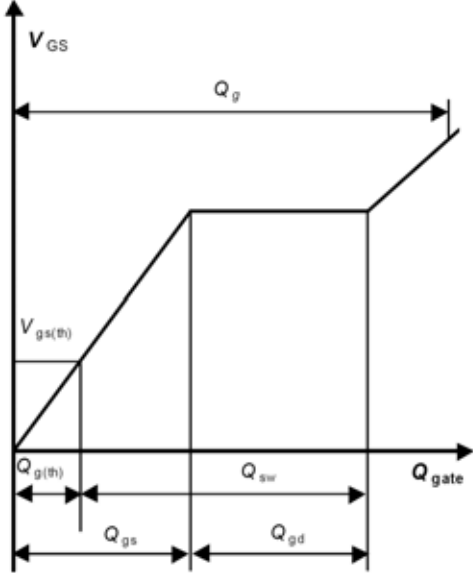
13 Avalanche characteristics	14 Typ. gate charge
 $I_{AS}=f(t_{AV})$; $R_{GS}=25\ \Omega$; parameter: $T_{j(start)}$	 $V_{GS}=f(Q_{gate})$; $I_D=30\text{ A}$ pulsed; parameter: V_{DD}

Table 15

15 Drain-source breakdown voltage	16 Gate charge waveforms
 $V_{BR(DSS)}=f(T_j)$; $I_D=1\text{ mA}$	

6 Package outlines

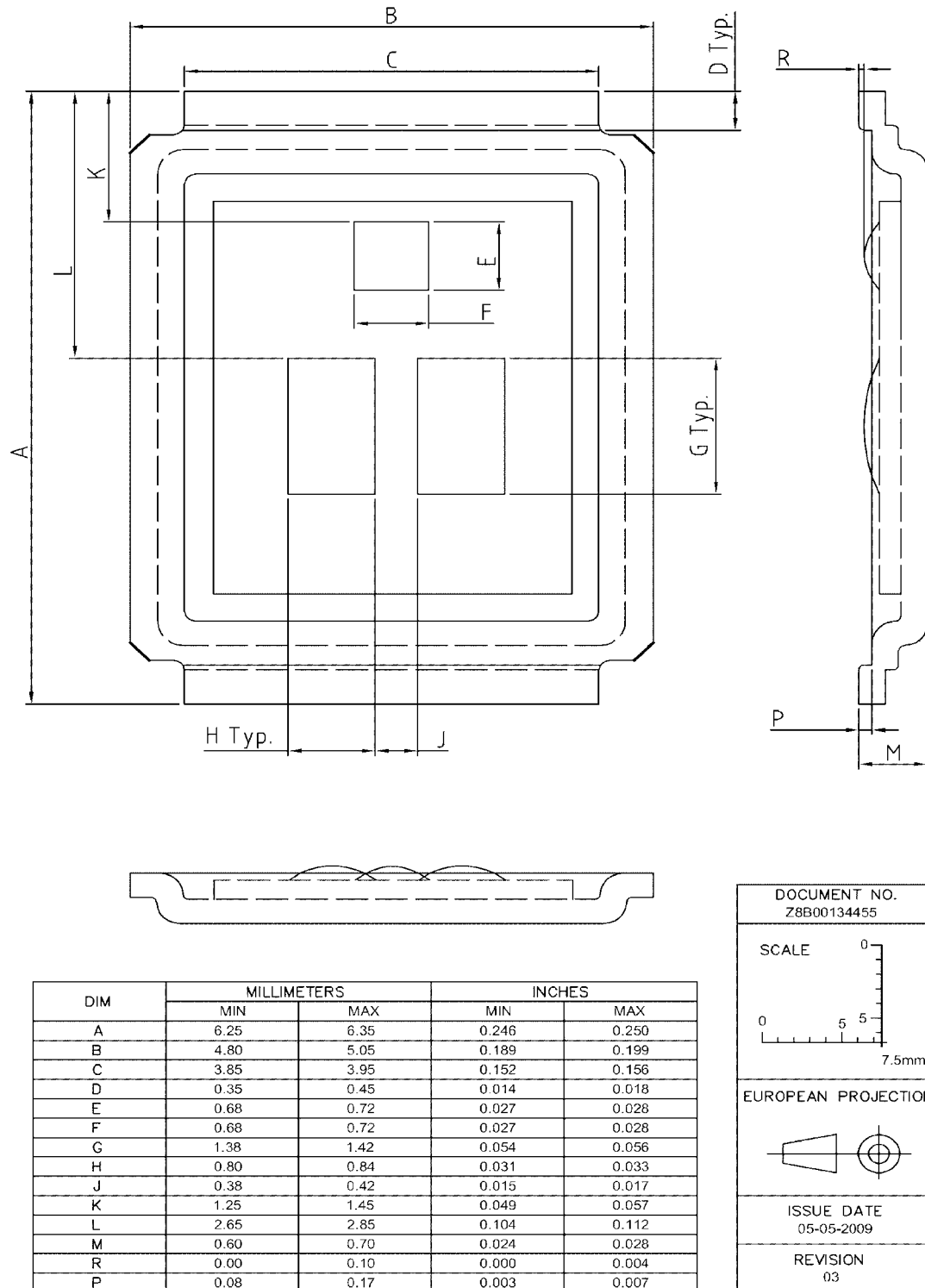


Figure 1 Outlines MG-WDSO-2, dimensions in mm/inches

7 Package outlines

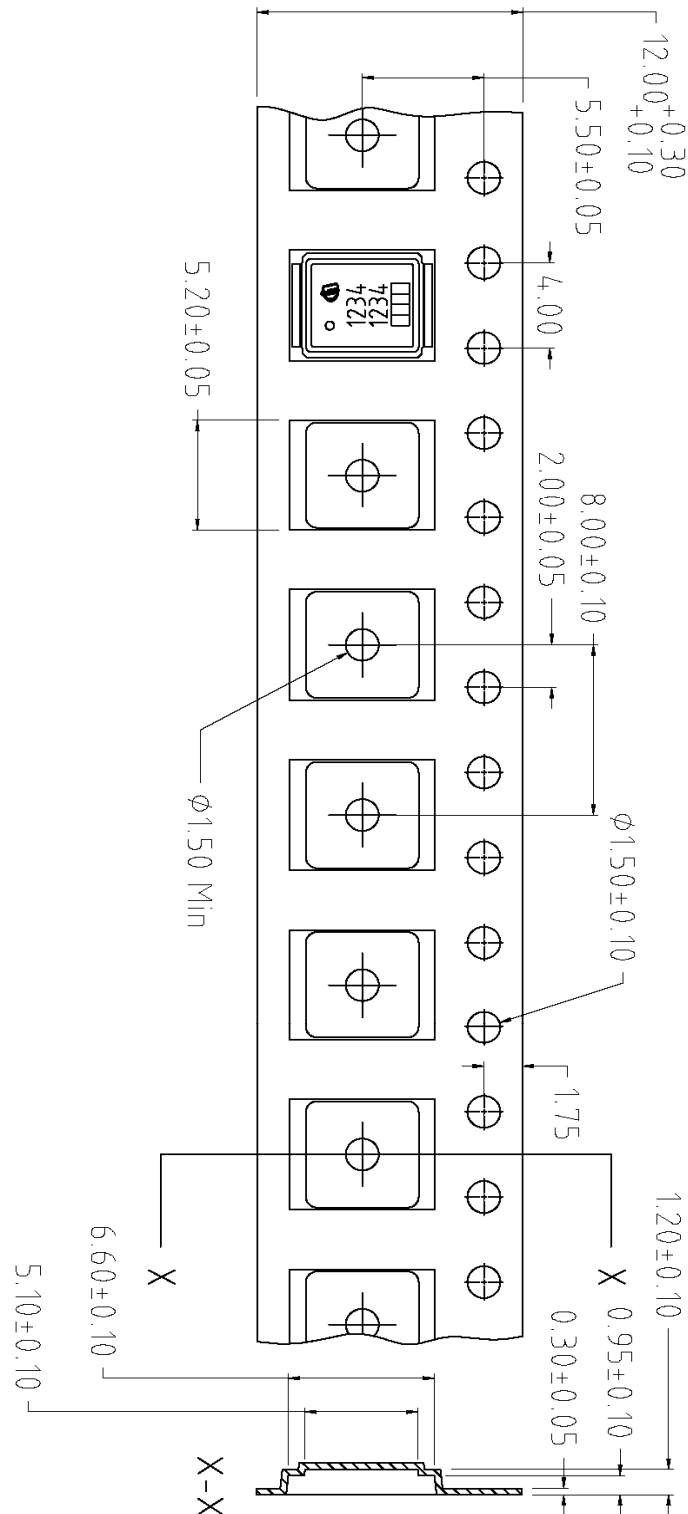
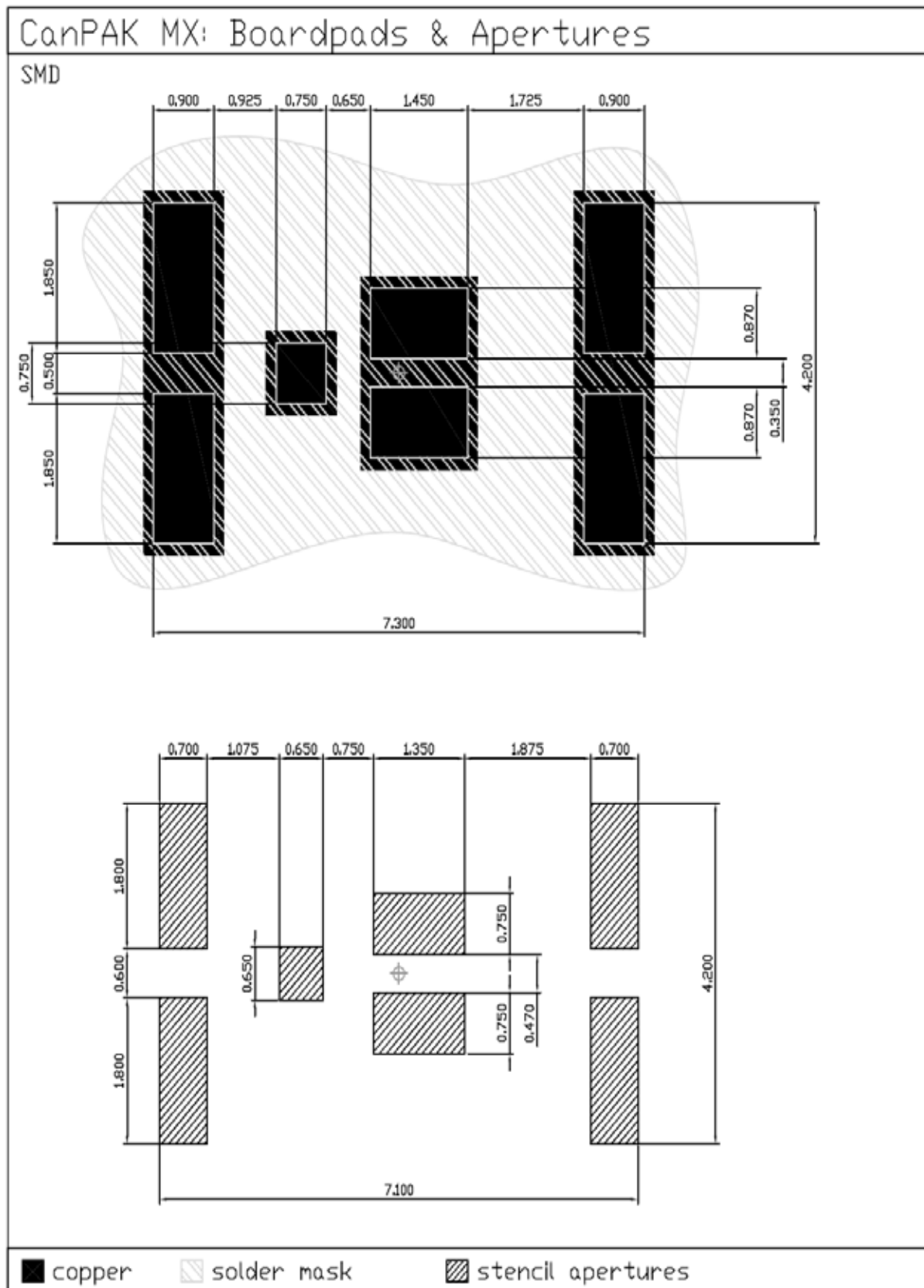


Figure 2 Outlines MG-WDSO-2, dimensions in mm/inches

8 Package outlines



9 Revision History

Revision History: 2011-03-21, 1.92

Previous Revision:

Revision	Subjects (major changes since last revision)
0.1	Release of target data sheet
1.9	Release of preliminary data sheet

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